

Microelectronics (ELEN0037) Formulary - 2016

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1 Constants

$$q = 1.602 \times 10^{-19} C$$

$$k = 1.38 \times 10^{-23} JK^{-1}$$

$$n_i = 1.1 \times 10^{16} \text{ carriers}/m^3 @ T = 300 K$$

n_i doubles for every 11°C increase in temperature

$$n \times p = n_i^2$$

$$\epsilon_0 = 8.854 \times 10^{-12} Fm^{-1}$$

$$K_{ox} \cong 3.9$$

$$K_s \cong 11.8$$

2 Diode

$$V_T = \frac{kT}{q} \cong 26 mV @ 300K$$

2.1 Reverse-Biased

$$Q = 2C_{j0}\Phi_0 \sqrt{1 + \frac{V_R}{\Phi_0}}$$

$$C_j = \frac{C_{j0}}{\sqrt{1 + \frac{V_R}{\Phi_0}}}$$

$$C_{j0} = \sqrt{\frac{qK_s\epsilon_0}{2\Phi_0} \frac{N_A N_D}{N_A + N_D}}$$

$$C_{j0} = \sqrt{\frac{qK_s\epsilon_0}{2\Phi_0} N_D} \text{ if } N_A \gg N_D$$

$$\Phi_0 = V_T \ln \left(\frac{N_A N_D}{n_i^2} \right)$$

2.2 Forward-Biased

$$I_D = I_S \exp \left(\frac{V_D}{V_T} \right)$$

$$I_S = A_D q n_i \left(\frac{D_n}{L_n N_A} + \frac{D_p}{L_p N_D} \right)$$

Small-Signal Model

$$r_d = \frac{V_T}{I_D}$$

$$C_T = C_d + C_j$$

$$C_d = \tau_t \frac{I_D}{V_T}$$

$$C_j \cong 2C_{j0}$$

3 N-channel MOSFET

For p-channel MOSFET, use the same equations as for the n-channel, with negative signs in front of all voltages.

$$V_{eff} = V_{GS} - V_{tn}$$

$$V_{tn} = V_{tn-0} + \gamma \left(\sqrt{V_{SB} + 2\Phi_F} - \sqrt{2\Phi_F} \right)$$

$$\Phi_F = V_T \ln \left(\frac{N_A}{n_i} \right) \text{ (see diode equations for } V_T)$$

$$\gamma = \frac{\sqrt{2qK_s\epsilon_0 N_A}}{C_{ox}}$$

$$C_{ox} = \frac{K_{ox}\epsilon_0}{t_{ox}}$$

3.1 Triode region ($V_{GS} > V_{tn}$, $V_{DS} \leq V_{eff}$)

$$I_D = \mu_n C_{ox} \left(\frac{W}{L} \right) \left[(V_{GS} - V_{tn}) V_{DS} - \frac{V_{DS}^2}{2} \right]$$

Small-Signal Model ($V_{DS} \ll V_{eff}$)

$$r_{ds} = \frac{\partial V_{DS}}{\partial I_D} = \frac{1}{\mu_n C_{ox} \left(\frac{W}{L} \right) (V_{eff} - V_{DS})} \cong \frac{1}{\mu_n C_{ox} \left(\frac{W}{L} \right) V_{eff}}$$

$$C_{gd} = C_{gs} \cong \frac{1}{2} W L C_{ox} + W L_{ov} C_{ox}$$

$$C_{sb} = C_{db} = \frac{C_{j0}(A_s + WL/2)}{\sqrt{1 + \frac{V_{sb}}{\Phi_0}}}$$

3.2 Active (Pinch-Off) Region ($V_{GS} > V_{tn}$, $V_{DS} \geq V_{eff}$)

$$I_D = \frac{1}{2} \mu_n C_{ox} \left(\frac{W}{L} \right) (V_{GS} - V_{tn})^2 [1 + \lambda (V_{DS} - V_{eff})]$$

$$\lambda = \frac{k_{ds}}{2L \sqrt{V_{DS} - V_{eff} + \Phi_0}}$$

$$k_{ds} = \sqrt{\frac{2K_s\epsilon_0}{qN_A}}$$

$$V_{eff} = V_{GS} - V_{tn} = \sqrt{\frac{2I_D}{\mu_n C_{ox} W/L}}$$

Small-Signal Model

$$g_m = \frac{\partial I_D}{\partial V_{GS}} = \mu_n C_{ox} \left(\frac{W}{L} \right) V_{eff} = \sqrt{2\mu_n C_{ox} \left(\frac{W}{L} \right) I_D} = \frac{2I_D}{V_{eff}}$$

$$g_s = \frac{\partial I_D}{\partial V_{SB}} = \frac{\gamma g_m}{2\sqrt{V_{SB} + 2\Phi_F}}$$

$$r_{ds} = \frac{\partial V_{DS}}{\partial I_D} \cong \frac{1}{\lambda I_D}$$

$$C_{gs} = \frac{2}{3} W L C_{ox} + W L_{ov} C_{ox} = \frac{2}{3} W L C_{ox} + W C_{gs-ov}$$

$$C_{gd} = W L_{ov} C_{ox} = W C_{gd-ov}$$

$$C_{sb} = (A_s + WL) C_{js} + P_s C_{j-sw}$$

$$C_{js} = \frac{C_{j0}}{\sqrt{1 + \frac{V_{sb}}{\Phi_0}}}$$

$$C_{db} = A_d C_{jd} + P_d C_{j-sw}$$

$$C_{jd} = \frac{C_{j0}}{\sqrt{1 + \frac{V_{db}}{\Phi_0}}}$$

3.3 Default values for MOSFET ($0.8 \mu m$)

n-channel $T = 300K$ (Room temperature) p-channel

$$\mu_n C_{ox} = 92 \mu A/V^2 \quad (30)$$

$$V_{tn-0} = 0.8V \quad (V_{tp-0} = -0.9V)$$

$$\gamma = 0.5V^{1/2} \quad (0.8)$$

$$r_{ds} (\Omega) = 8000L (\mu m) / I_D (mA) \text{ in active region} \quad (12000)$$

$$C_{js} = C_{jd} (= C_j) = 2.4 \times 10^{-4} pF / (\mu m)^2 \quad (4.5 \times 10^{-4})$$

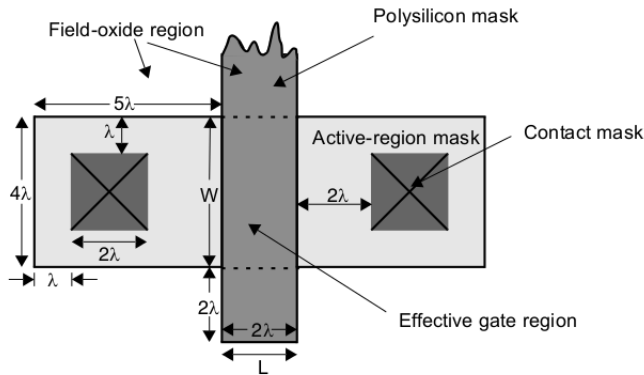
$$C_{j-sw} = 2.0 \times 10^{-4} pF / \mu m \quad (2.5 \times 10^{-4})$$

$$C_{ox} = 1.9 \times 10^{-3} pF / (\mu m)^2 \quad (1.9 \times 10^{-3})$$

$$C_{gs-ov} = C_{gd-ov} = 2.0 \times 10^{-4} pF / \mu m \quad (2.0 \times 10^{-4})$$

4 Design rules

The design rules are expressed in terms of a quantity, λ , where λ is $1/2$ the minimum permitted gate length ($L = 2\lambda$). The corresponding layout of the active, polysilicon, and contact masks of the smallest transistor that can be realized in a given process when a contact must be made to each junction is summarized hereafter



The n well surrounds the p-channel MOST, by at least 3λ . The minimum spacing between the n well and the junctions of n-channel MOST is 5λ . Therefore, the closest an n-channel MOST can be placed to a p-channel MOST is 8λ . The minimum widths of poly, metal 1, and metal 2 are 2λ , 2λ , and $\lambda/3$, respectively.

5 Filters

5.1 First order

$$\text{General form} \quad H(s) = \frac{k_1 s + k_0}{s + \Omega_0}$$

$$\text{Low Pass} \quad H(s) = \frac{\Omega_0}{s + \Omega_0}$$

$$\text{High Pass} \quad H(s) = \frac{s}{s + \Omega_0}$$

5.2 Second order (Biquad)

$$\text{General form} \quad H(s) = \frac{k_2 s^2 + k_1 s + k_0}{s^2 + (\Omega_0/Q) s + \Omega_0^2}$$

$$\text{Low Pass} \quad H(s) = \frac{\Omega_0^2}{s^2 + (\Omega_0/Q) s + \Omega_0^2}$$

$$\text{Band Pass} \quad H(s) = \frac{(\Omega_0/Q) s}{s^2 + (\Omega_0/Q) s + \Omega_0^2}$$

$$\text{Band Stop} \quad H(s) = \frac{s^2 + \Omega_0^2}{s^2 + (\Omega_0/Q) s + \Omega_0^2}$$

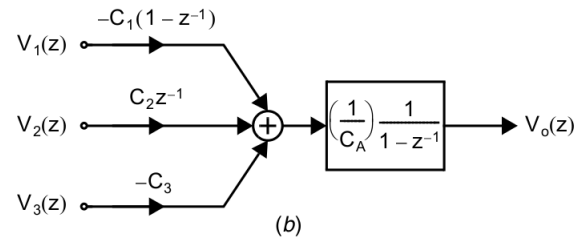
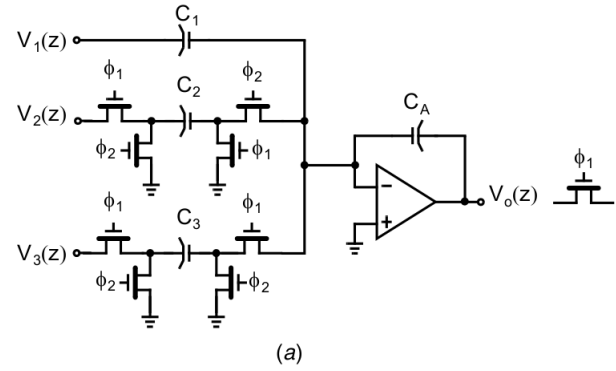
$$\text{High Pass} \quad H(s) = \frac{s^2}{s^2 + (\Omega_0/Q) s + \Omega_0^2}$$

6 Z transform

Exact transform	Bilinear transform
$z = e^{j\omega T}$	$s = \frac{z-1}{z+1}, z = \frac{1+s}{1-s}$
$z \approx 1 + j\omega T$ if $\omega T \ll 1$	$\Omega_{s\text{-domain}} = \tan\left(\frac{\omega_{z\text{-domain}}}{2}\right)$

7 Switched-capacitor circuits

7.1 Signal-Flow-Graph Analysis



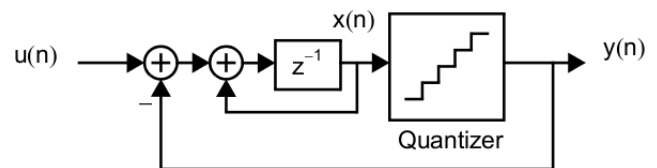
8 Data converters

Number of bits: N , number of levels: $L = 2^N$, quantization error: $\Delta = \frac{V_{ref}}{L}$, RMS error: $e_{rms} = \Delta/\sqrt{12}$, oversampling rate: $OSR = \frac{f_s}{2f_0}$.

Converter type	Signal to noise ratio $SQNR_{max}$
Nyquist rate ($OSR = 1$)	$6.02N + 1.76$
Oversamp., no noise shaping	$6.02N + 1.76 + 10 \log OSR$
Oversamp., 1^{st} -order noise shaping	$6.02N + 1.76 - 5.17 + 30 \log OSR$
Oversamp., 2^{nd} -order noise shaping	$6.02N + 1.76 - 12.9 + 50 \log OSR$

These formulae are valid (1) for an input sine wave (otherwise remove the +1.76 term), and (2) when the input signal spans the full range of the converter.

8.1 first-order $\Sigma\Delta$ modulator



The state equations of the first-order $\Sigma\Delta$ modulator are given by:

$$\begin{aligned} y(n) &= Q(x(n)) \\ e(n) &= y(n) - x(n) \\ x(n+1) &= x(n) + u(n) - y(n) \end{aligned}$$

9 Noise Analysis and Modeling

Spectral Density: $V_n^2(f) \quad [V^2/Hz]$.
 Root Spectral Density: $V_n(f) \quad [V/\sqrt{Hz}]$.
 Total noise power: $V_n^2 = \int_0^\infty V_n^2(f) df \quad [V^2]$.

Sum of two noise sources

$$V_n^2 = V_{n1}^2 + V_{n2}^2 + 2CV_{n1}V_{n2},$$

$$P_n = P_{n1} + P_{n2} + 2C\sqrt{(P_1P_2)}.$$

White noise: $V_n^2(f) = k_w^2$

Pink (Flicker or $\frac{1}{f}$) noise: $V_n^2(f) = \frac{k_f^2}{f}$

Filtered noise: $V_{no}^2(f) = |A(f)|^2 V_{ni}^2(f)$

Voltage noise across a resistor: $V_R^2(f) = 4kTR$

Accumulated Voltage noise across a capacitor: $V_C^2 = \frac{kT}{C}$

Accumulated Current noise across an inductor: $I_L^2 = \frac{kT}{L}$

10 Miscellaneous

Matching accuracy for capacitors

We desire to match C_1 and C_2 , such that $K = \frac{C_2}{C_1} \geq 1$.

Analysis gives the condition $\frac{P_1}{A_1} = \frac{P_2}{A_2}$.

Therefore $K = \frac{C_2}{C_1} = \frac{A_2}{A_1} = \frac{P_2}{P_1}$.

If C_1 is a square of size $x_1 \times x_1$, and C_2 has size $x_2 \times y_2$, we have:

$$y_2 = x_1 \left(K \pm \sqrt{(K^2 - K)} \right)$$

$$x_2 = K \frac{x_1^2}{y_2}$$

Square resistance

$$R_{\square} = \frac{\rho}{H} = \frac{1}{q\mu_n N_D H}$$

$$R = R_{\square} \frac{L}{W}$$

Signal to noise ratio (SNR), decibels

$$SNR = 10 \log \left(\frac{P_{signal}}{P_{noise}} \right) \quad [dB]$$

Conversion from power to dB: $10 \log(P)$

Conversion from power to dBm (dB mW): $10 \log \left(\frac{P}{1mW} \right)$

Conversion from voltage to dB: $20 \log(V)$

Conversion from voltage to dBm (dB mV): $20 \log \left(\frac{V}{1mV} \right)$

Steady state percentage value of first order filter versus time constant τ

Time	Percentage
τ	63%
2τ	86%
3τ	95%
4τ	98%
5τ	99%